

April 2011

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FDMS86520L

N-Channel PowerTrench® MOSFET 60 V, 22 A, 8.2 m Ω

Features

- Max $r_{DS(on)} = 8.2 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 13.5 \text{ A}$
- Max $r_{DS(on)} = 11.7 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 11.5 \text{ A}$
- Advanced package and silicon combination for low r_{DS(on)} and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

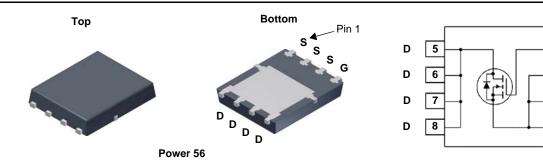


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers.It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- Primary Switch in isolated DC-DC
- Synchronous Rectifier
- Load Switch



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			60	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		22	
I _D	-Continuous (Silicon limited)	T _C = 25 °C		71	
	-Continuous	T _A = 25 °C	(Note 1a)	13.5	Α
	-Pulsed			60	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	91	mJ
В	Power Dissipation	T _C = 25 °C		69	W
P_D	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86520L	FDMS86520L	Power 56	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted Parameter

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		29		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-7		mV/°C
	V _{GS} = 10 V, I _D = 13.5 A		6.7	8.2		
r	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 11.5 \text{ A}$		9.1	11.7	mΩ
r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_{D} = 13.5 \text{ A},$ $T_{J} = 125 ^{\circ}\text{C}$		9.6	11.8	- 11152	
g _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 13.5 A		51		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 00 V V 0 V	3470	4615	рF
Coss	Output Capacitance	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	625	835	рF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	25	45	pF
R_a	Gate Resistance		0.6		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			15	27	ns
t _r	Rise Time	V _{DD} = 30 V, I _D = 13.5 A,	$V_{DD} = 30 \text{ V, } I_{D} = 13.5 \text{ A,}$ $V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega$		11	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$			52	ns
t _f	Fall Time			3.4	10	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V		45	63	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 30 \text{ V},$		21	30	nC
Q _{gs}	Gate to Source Charge	I _D = 13.5 A		9.5		nC
Q_{gd}	Gate to Drain "Miller" Charge			4.7		nC

Drain-Source Diode Characteristics

V _{SD} Source-Drain Diode Fo	Source Drain Diede Ferward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)	0.72	1.2	\/
	Source-Drain blode Forward voltage	V _{GS} = 0 V, I _S = 13.5 A (Note 2)	0.83	1.3	v
t _{rr}	Reverse Recovery Time	I _E = 13.5 A, di/dt = 100 A/μs	37	60	ns
Q _{rr}	Reverse Recovery Charge		21	34	nC
t _{rr}	Reverse Recovery Time	I _E = 13.5 A, di/dt = 300 A/μs	30	48	ns
Q_{rr}	Reverse Recovery Charge		37	59	nC

^{1.} $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. Starting T_J = 25 °C, L = 1 mH, I_{AS} = 13.5 A, V_{DD} = 54 V, V_{GS} = 10 V.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

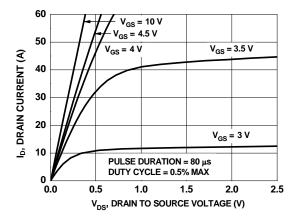


Figure 1. On Region Characteristics

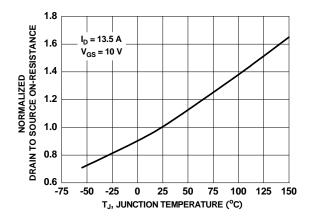


Figure 3. Normalized On Resistance vs Junction Temperature

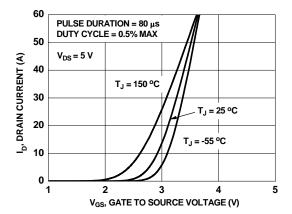


Figure 5. Transfer Characteristics

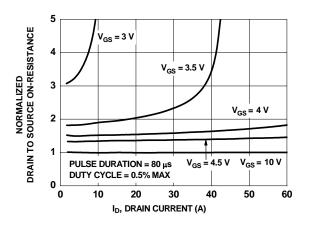


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

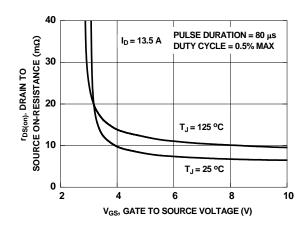


Figure 4. On-Resistance vs Gate to Source Voltage

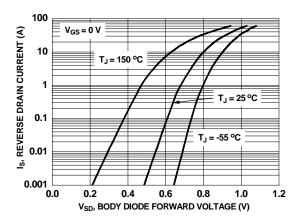


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

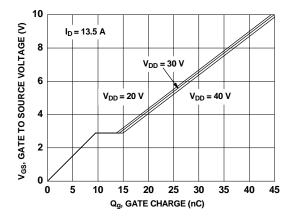


Figure 7. Gate Charge Characteristics

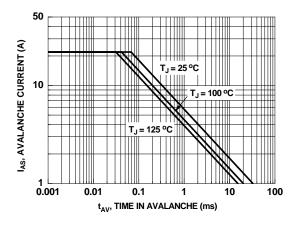


Figure 9. Unclamped Inductive Switching Capability

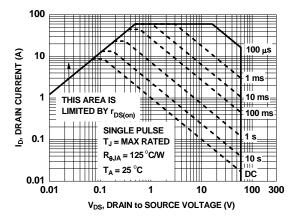


Figure 11. Forward Bias Safe Operating Area

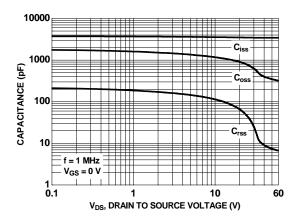


Figure 8. Capacitance vs Drain to Source Voltage

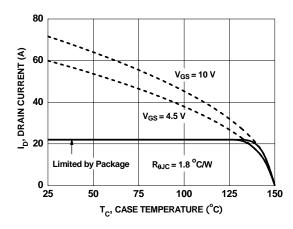


Figure 10. Maximum Continuous Drain Current vs Case Temperature

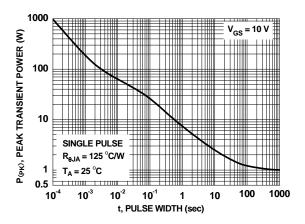


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

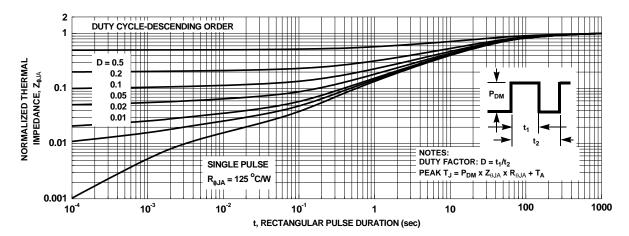
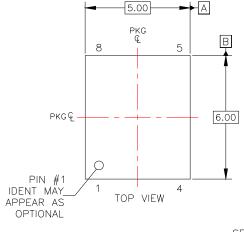
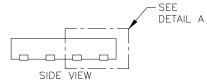
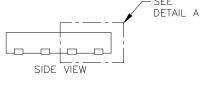


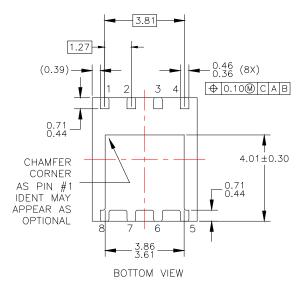
Figure 13. Junction-to-Ambient Transient Thermal Response Curve

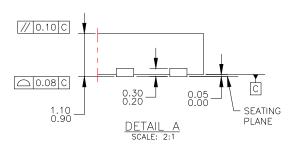
Dimensional Outline and Pad Layout

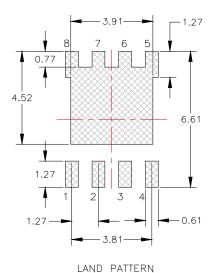




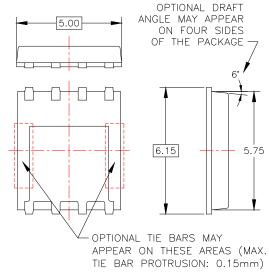








RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

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 DIMENSIONS DO NOT INCLUDE BURRS
 OR MOLD FLASH. MOLD FLASH OR
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		Rev 153